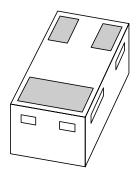
DISCRETE SEMICONDUCTORS

DATA SHEET



PBSS2540M 40 V, 0.5 A NPN low V_{CEsat} (BISS) transistor

Product specification

2003 Jul 22





40 V, 0.5 A NPN low V_{CEsat} (BISS) transistor

PBSS2540M

FEATURES

- Low collector-emitter saturation voltage V_{CEsat}
- \bullet High collector current capability I_{C} and I_{CM}
- · High efficiency leading to reduced heat generation
- Reduced printed-circuit board requirements.

APPLICATIONS

- Power management:
 - DC-DC converter
 - Supply line switching
 - Battery charger
 - LCD backlighting.
- · Peripheral driver:
 - Driver in low supply voltage applications (e.g. lamps and LEDs).
 - Inductive load drivers (e.g. relays, buzzers and motors).

DESCRIPTION

Low V_{CEsat} NPN transistor in a SOT883 leadless ultra small plastic package. PNP complement: PBSS3540M.

MARKING

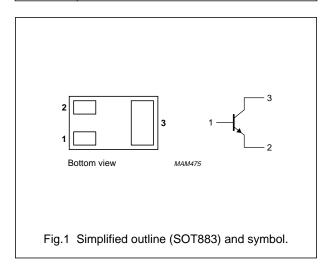
TYPE NUMBER	MARKING CODE	
PBSS2540M	DC	

QUICK REFERENCE DATA

SYMBOL	PARAMETER	MAX.	UNIT
V _{CEO}	collector-emitter voltage	40	V
I _C	collector current (DC)		mA
I _{CM} peak collector current 1		1	Α
R _{CEsat} equivalent on-resistance <500 n		mΩ	

PINNING

PIN	DESCRIPTION	
1	base	
2	emitter	
3	collector	



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LIMITING VALUES

In accordance with the Absolute Maximum Rating System (IEC 60134).

SYMBOL	PARAMETER	IETER CONDITIONS		MAX.	UNIT
V _{CBO}	collector-base voltage	open emitter	_	40	V
V _{CEO}	collector-emitter voltage	open base	_	40	V
V _{EBO}	emitter-base voltage	open collector	_	6	V
Ic	collector current (DC)	notes 1 and 2	_	500	mA
I _{CM}	peak collector current		_	1	Α
I _{BM}	peak base current		_	100	mA
P _{tot}	total power dissipation	T _{amb} ≤ 25 °C; notes 1 and 2	_	250	mW
		T _{amb} ≤ 25 °C; note 1 and 3	_	430	mW
T _{stg}	storage temperature		-65	+150	°C
Tj	junction temperature		_	150	°C
T _{amb}	operating ambient temperature		-65	+150	°C

Notes

- 1. Refer to SOT883 standard mounting conditions.
- Device mounted on an FR4 printed-circuit board, single-sided copper, tinplated, standard footprint, with 60 μm copper strip line.
- 3. Device mounted on a printed-circuit board, single-sided copper, tinplated, mounting pad for collector 1 cm².

THERMAL CHARACTERISTICS

SYMBOL	PARAMETER	CONDITIONS	VALUE	UNIT
R _{th j-a}	thermal resistance from junction to	in free air; notes 1 and 2	500	K/W
	ambient	in free air; notes 1, 3 and 4	290	K/W

Notes

- 1. Refer to SOT883 standard mounting conditions.
- 2. Device mounted on an FR4 printed-circuit board, single-sided copper, tinplated, standard footprint, with 60 μ m copper strip line.
- 3. Device mounted on a printed-circuit board, single-sided copper, tinplated, mounting pad for collector 1 cm².
- 4. Operated under pulsed conditions: duty cycle $\delta \le 20\%$, pulse width $t_p \le 30$ ms.

Soldering

Reflow soldering is the only recommended soldering method.

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CHARACTERISTICS

 T_{amb} = 25 $^{\circ}C$ unless otherwise specified.

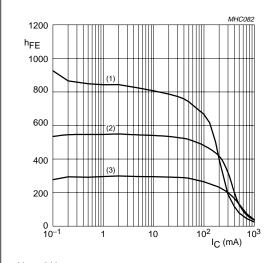
SYMBOL	OL PARAMETER CONDITIONS		MIN.	TYP.	MAX.	UNIT
I _{CBO}	collector-base cut-off current	V _{CB} = 30 V; I _E = 0	_	_	100	nA
		V _{CB} = 30 V; I _E = 0; T _j = 150 °C	_	_	50	μΑ
I _{EBO}	emitter-base cut-off current	V _{EB} = 5 V; I _C = 0	_	_	100	nA
h _{FE}	DC current gain	V _{CE} = 2 V; I _C = 10 mA	200	_	_	
		V _{CE} = 2 V; I _C = 100 mA; note 1	150	_	_	
		V _{CE} = 2 V; I _C = 500 mA; note 1	50	_	_	
V _{CEsat}	collector-emitter saturation voltage	I _C = 10 mA; I _B = 0.5 mA	_	_	50	mV
		I _C = 100 mA; I _B = 5 mA	_	_	100	mV
		I _C = 200 mA; I _B = 10 mA; note 1	_	_	200	mV
		I _C = 500 mA; I _B = 50 mA; note 1	_	_	250	mV
R _{CEsat}	equivalent on-resistance	I _C = 500 mA; I _B = 50 mA; note 1	_	380	<500	mΩ
V _{BEsat}	base-emitter saturation voltage	I _C = 500 mA; I _B = 50 mA; note 1	_	_	1.2	V
V_{BEon}	base-emitter turn-on voltage	V _{CE} = 2 V; I _C = 100 mA; note 1	_	_	1.1	V
f _T	transition frequency	I _C = 100 mA; V _{CE} = 5 V; f = 100 MHz	250	450	_	MHz
C _c	collector capacitance	$V_{CB} = 10 \text{ V}; I_E = I_e = 0; f = 1 \text{ MHz}$	_	_	6	pF

Note

1. Pulse test: $t_p \le 300~\mu s;~\delta \le 0.02.$

40 V, 0.5 A NPN low V_{CEsat} (BISS) transistor

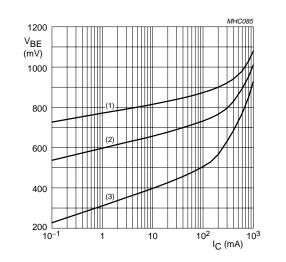
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 $V_{CE} = 2 V$.

- (1) $T_{amb} = 150 \, ^{\circ}C$.
- (2) $T_{amb} = 25 \, ^{\circ}C$.
- (3) $T_{amb} = -55 \, ^{\circ}C$.

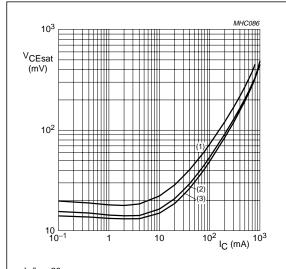
Fig.2 DC current gain as a function of collector current; typical values.



 $V_{CE} = 2 V.$

- (1) $T_{amb} = -55 \, ^{\circ}C$.
- (2) $T_{amb} = 25 \, ^{\circ}C$.
- (3) $T_{amb} = 150 \, ^{\circ}C$

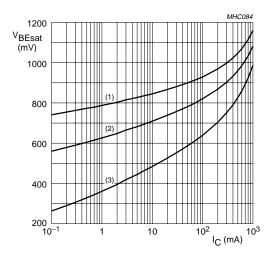
Fig.3 Base-emitter voltage as a function of collector current; typical values.



 $I_{\rm C}/I_{\rm B}=20.$

- (1) $T_{amb} = 150 \, ^{\circ}C$.
- (2) $T_{amb} = 25 \, ^{\circ}C$.
- (3) $T_{amb} = -55 \, ^{\circ}C$.

Fig.4 Collector-emitter saturation voltage as a function of collector current; typical values.



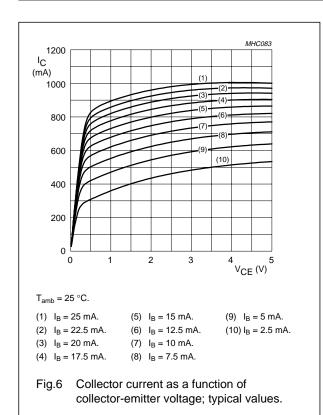
 $I_{\rm C}/I_{\rm B} = 20.$

- (1) $T_{amb} = 150 \, ^{\circ}C$.
- (2) T_{amb} = 25 °C.
- (3) $T_{amb} = -55 \,^{\circ}\text{C}$.

Fig.5 Base-emitter saturation voltage as a function of collector current; typical values.

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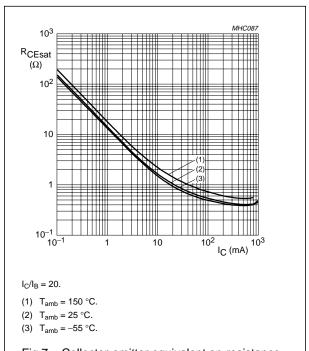


Fig.7 Collector-emitter equivalent on-resistance as a function of collector current; typical values

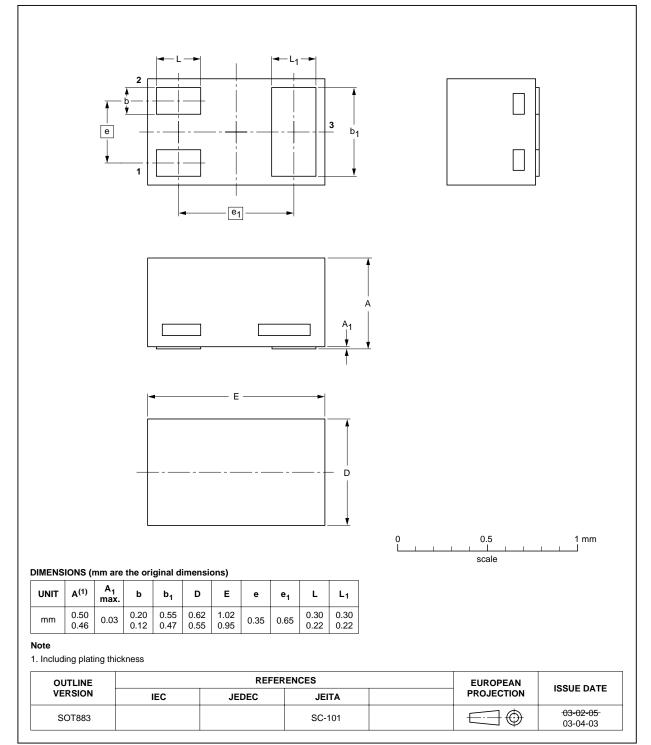
40 V, 0.5 A NPN low V_{CEsat} (BISS) transistor

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PACKAGE OUTLINE

Leadless ultra small plastic package; 3 solder lands; body 1.0 x 0.6 x 0.5 mm

SOT883



40 V, 0.5 A NPN low V_{CEsat} (BISS) transistor

PBSS2540M

DATA SHEET STATUS

LEVEL	DATA SHEET STATUS ⁽¹⁾	PRODUCT STATUS ⁽²⁾⁽³⁾	DEFINITION
I	Objective data	Development	This data sheet contains data from the objective specification for product development. Philips Semiconductors reserves the right to change the specification in any manner without notice.
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Notes

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DEFINITIONS

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Limiting values definition — Limiting values given are in accordance with the Absolute Maximum Rating System (IEC 60134). Stress above one or more of the limiting values may cause permanent damage to the device. These are stress ratings only and operation of the device at these or at any other conditions above those given in the Characteristics sections of the specification is not implied. Exposure to limiting values for extended periods may affect device reliability.

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